Applicant(s)/Patent Under Application/Control No. Reexamination 10/623,896 HE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3766 Yun H. Lee **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 439/496 Swanson, John W. US-6,368,147 04-2002 Α В US-US-С US-D US-Ε F US-US-G US-Н US-1 US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Name Country MM-YYYY Country Code-Number-Kind Code 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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